

Tailoring photoluminescence from Si-based nanocrystals prepared by pulsed laser ablation in He-N₂ gas mixtures

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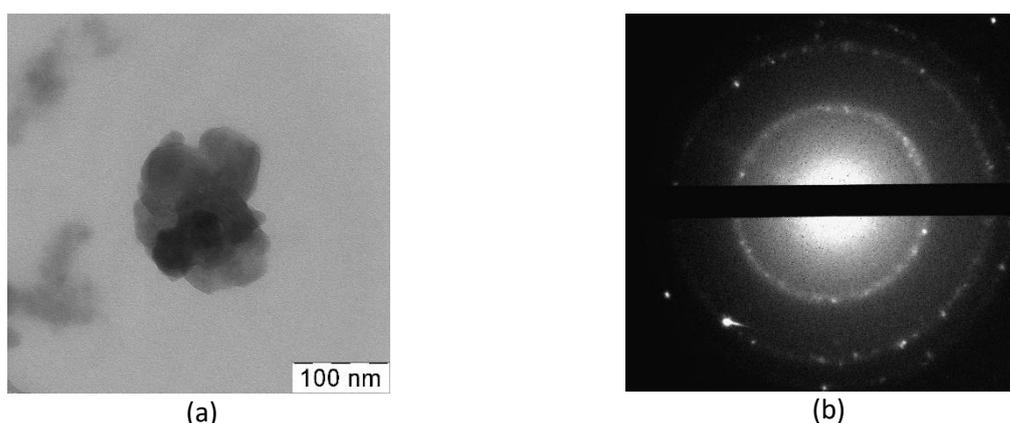


Figure S1. TEM images (a) and electron diffraction pattern (b) of NPs from S-1 sample.

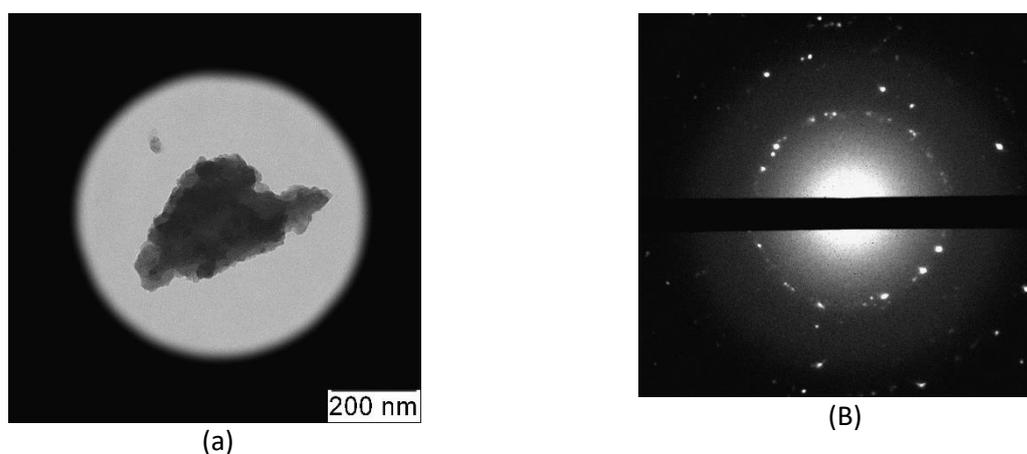


Figure S2. TEM images (a) and electron diffraction pattern (b) of NPs from S-2 sample.

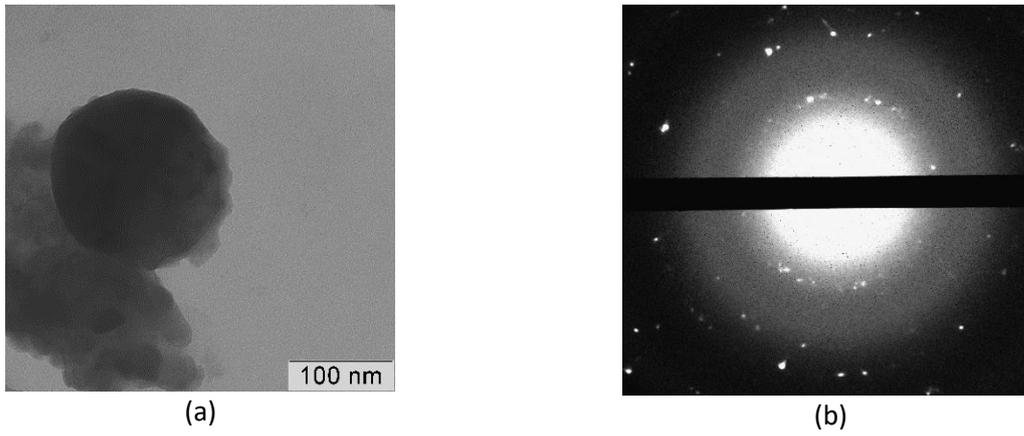


Figure S3. TEM images (a) and electron diffraction pattern (b) of NPs from S-3 sample.

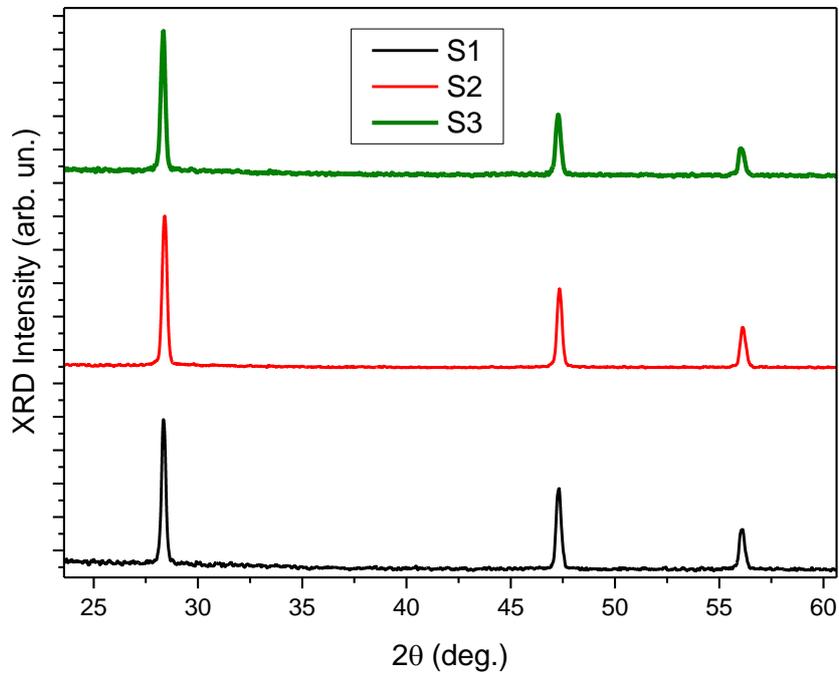


Figure S4. XRD spectra of NPs from samples S-1, S-2 and S-3.

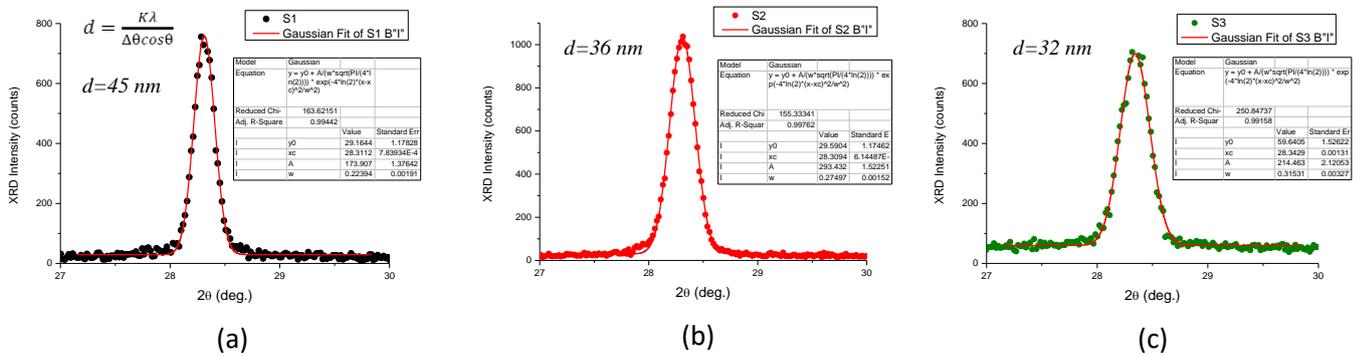


Figure S5. XRD spectra and their analysis in a vicinity of the (111) peak for NPs from samples S-1 (a), S-2 (b), S-3 (c).